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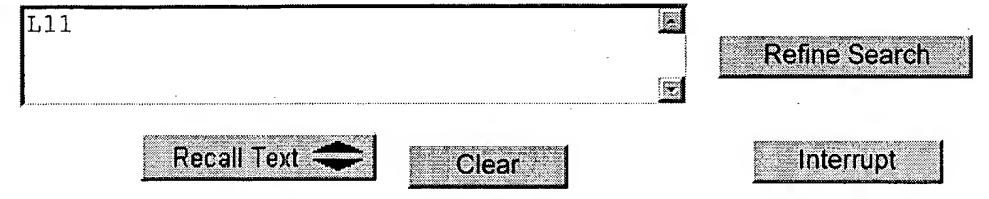
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1 Fast panoramic stereo matching using cylindrical maximum surface!

Changming Sun; Peleg, S.;

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Pages:760 - 765

[Abstract] [PDF Full-Text (368 KB)] IEEE JNL

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Yocky, D.A.; Wahl, D.E.; Jakowatz, C.V., Jr.;

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O- By Author O- Basic O- Advanced O- CrossRef	Measuring photolithographic overlay accuracy and critical dimensions by correlating binarized Laplacian of Gaussian convolutions  Nishihara, H.K.; Crossley, P.A.;  Pattern Analysis and Machine Intelligence, IEEE Transactions on , Volume:  10 , Issue: 1 , Jan. 1988
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